Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/601,645	MATSUISHI, TAKAYA	•
Examiner	Art Unit	
Merilyn P. Nauven	2163	

	SEARCHED		
Class	Subclass	Date	Examiner
707	1,5,104.1	12/10/2005	MN

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARC (INCLUDING SE	CH NOTES ARCH STRATEGY)
	DATE	EXMR
East searched .	12/10/2005	MN